UTT100N06 **Power MOSFET** 

# 100A, 60V N-CHANNEL **ENHANCEMENT MODE POWER** MOSFET

## **DESCRIPTION**

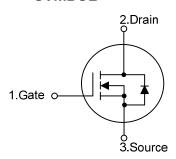
The UTC UTT100N06 is an N-channel enhancement mode Power FET using UTC's advanced technology to provide customers with a minimum on-state resistance and superior switching performance.

It also can withstand high energy pulse in the avalanche and commutation mode.

## **FEATURES**

- \* Fast switching speed
- \*  $R_{DS(ON)}$  < 7.0m $\Omega$  @  $V_{GS}$ =10V,  $I_D$ =50A
- \* 100% avalanche tested
- \* Improved dv/dt capability

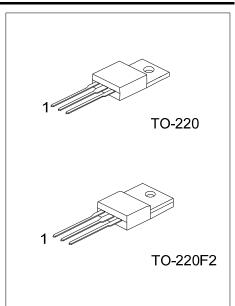
#### **SYMBOL**



#### ORDERING INFORMATION

Ordering Number		Dooleage	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UTT100N06L-TA3-T	UTT100N06G-TA3-T	TO-220	G	D	S	Tube	
UTT100N06L-TF2-T	UTT100N06G-TF2-T	TO-220F2	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source UTT100N06G-TA3-T (1)Packing Type (1) T: Tube (2)Package Type (2) TA3: TO-220, TF2: TO-2201 (3) G: Halogen Free and Lead Free, L: Lead Free (3)Green Package SWWW. Flyin



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# ABSOLUTE MAXIMUM RATINGS (T<sub>J</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	60	V
Gate-Source Voltage		$V_{GSS}$	±20	V
Drain Current	Continuous	I <sub>D</sub>	100	Α
	Pulsed	I <sub>DM</sub>	400	Α
Avalanche Energy Single Pulsed		E <sub>AS</sub>	450	mJ
Peak Diode Recovery dv/dt		dv/dt	6	V/ns
Power Dissipation	TO-220	В	100	W
	TO-220F2	P <sub>D</sub>	63	W
Junction Temperature		$T_J$	+150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

## THERMAL CHARACTERISTICS

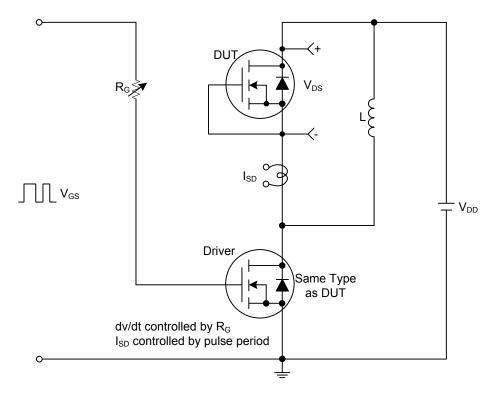
PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		$\theta_{JA}$	62.5	°C/W
Junction to Case	TO-220	0	1.5	°C/W
	TO-220F2	$\theta_{ m JC}$	1.98	°C/W

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C, unless otherwise specified)

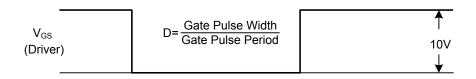
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		$BV_{DSS}$	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	60			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V			10	μΑ
Gate- Source Leakage Current	Forward	I <sub>GSS</sub>	V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V			+100	nA
	Reverse		V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	1.0		3.0	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =50A			7.0	mΩ
DYNAMIC PARAMETERS					<u>.</u>		_
Input Capacitance		$C_{ISS}$			12900		pF
Output Capacitance		Coss	$V_{GS}$ =0V, $V_{DS}$ =25V, f=1.0MHz		1060		pF
Reverse Transfer Capacitance		$C_{RSS}$			700		pF
SWITCHING PARAMETERS							
Total Gate Charge		$Q_G$			500		nC
Gate to Source Charge		$Q_GS$	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =100A		50		nC
Gate to Drain Charge		$Q_GD$			33		nC
Turn-ON Delay Time		$t_{D(ON)}$			90		ns
Rise Time		$t_R$	$V_{DD}$ =30V, $V_{GS}$ =10V,		130	200	ns
Turn-OFF Delay Time		$t_{D(OFF)}$	I <sub>D</sub> ≒100A, R <sub>G</sub> =0.4Ω		768		ns
Fall-Time		t⊧			280	420	ns
Transconductance		<b>g</b> FS	V <sub>DS</sub> =15V, I <sub>D</sub> =30A	30			S
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS							
Maximum Body-Diode Continuous Current		Is	R. V.	100			Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>	X IVO C	400			Α
Drain-Source Diode Forward Voltage		$V_{SD}$	I <sub>S</sub> =100A, V <sub>GS</sub> =0V		1.0	1.5	V
Resistance of Gate		R <sub>G</sub>	W LY OT	0.65	1.3	2	Ω

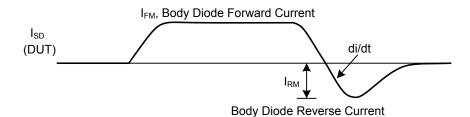
2. Essentially independent of operating temperature. Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

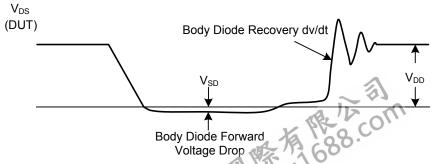
## ■ TEST CIRCUITS AND WAVEFORMS



## Peak Diode Recovery dv/dt Test Circuit



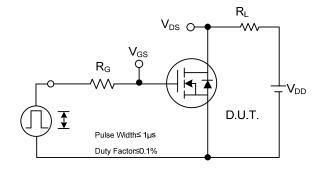




Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

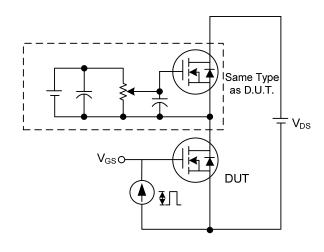
## **TEST CIRCUITS AND WAVEFORMS**

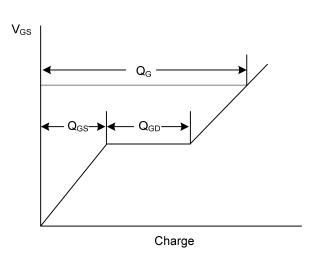


90% 10% V<sub>GS</sub> -

**Switching Test Circuit** 

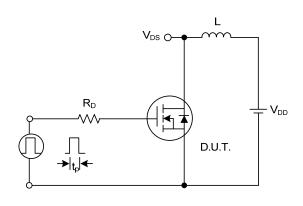
**Switching Waveforms** 

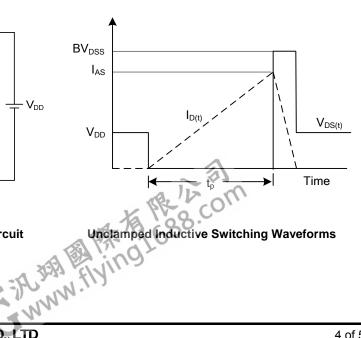




**Gate Charge Test Circuit** 

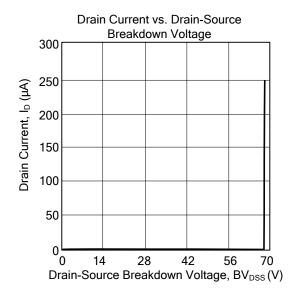
**Gate Charge Waveform** 

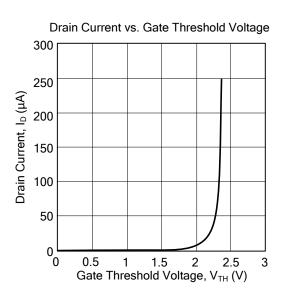


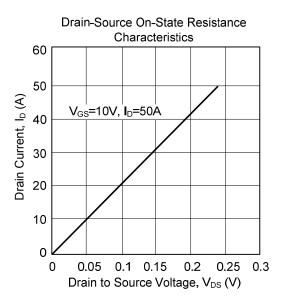


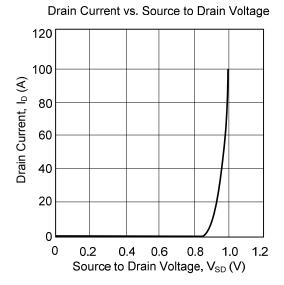
**Unclamped Inductive Switching Test Circuit** 

#### **■ TYPICAL CHARACTERISTICS**









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